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(12) **United States Design Patent**
Yokino et al.

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- (54) **SPECTROMETER**
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- (**) Term: **15 Years**
- (21) Appl. No.: **29/705,042**
- (22) Filed: **Sep. 9, 2019**

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(Continued)

Related U.S. Application Data

- (60) Division of application No. 29/627,946, filed on Nov. 30, 2017, now Pat. No. Des. 880,323, which is a continuation of application No. 35/501,554, filed on Mar. 15, 2016 (U.S. filing date under 35 U.S.C. 384), and having an international filing date of Mar. 15, 2016, now Pat. No. Des. 812,502.
- (51) **LOC (13) Cl.** **10-04**
- (52) **U.S. Cl.**
USPC **D10/81**
- (58) **Field of Classification Search**
USPC D10/47, 81, 104.1, 158; D13/159, 160
CPC G01B 1/00; G01J 3/0256; G01N 21/67
See application file for complete search history.

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(57) **CLAIM**

The ornamental design for a spectrometer, as shown and described.

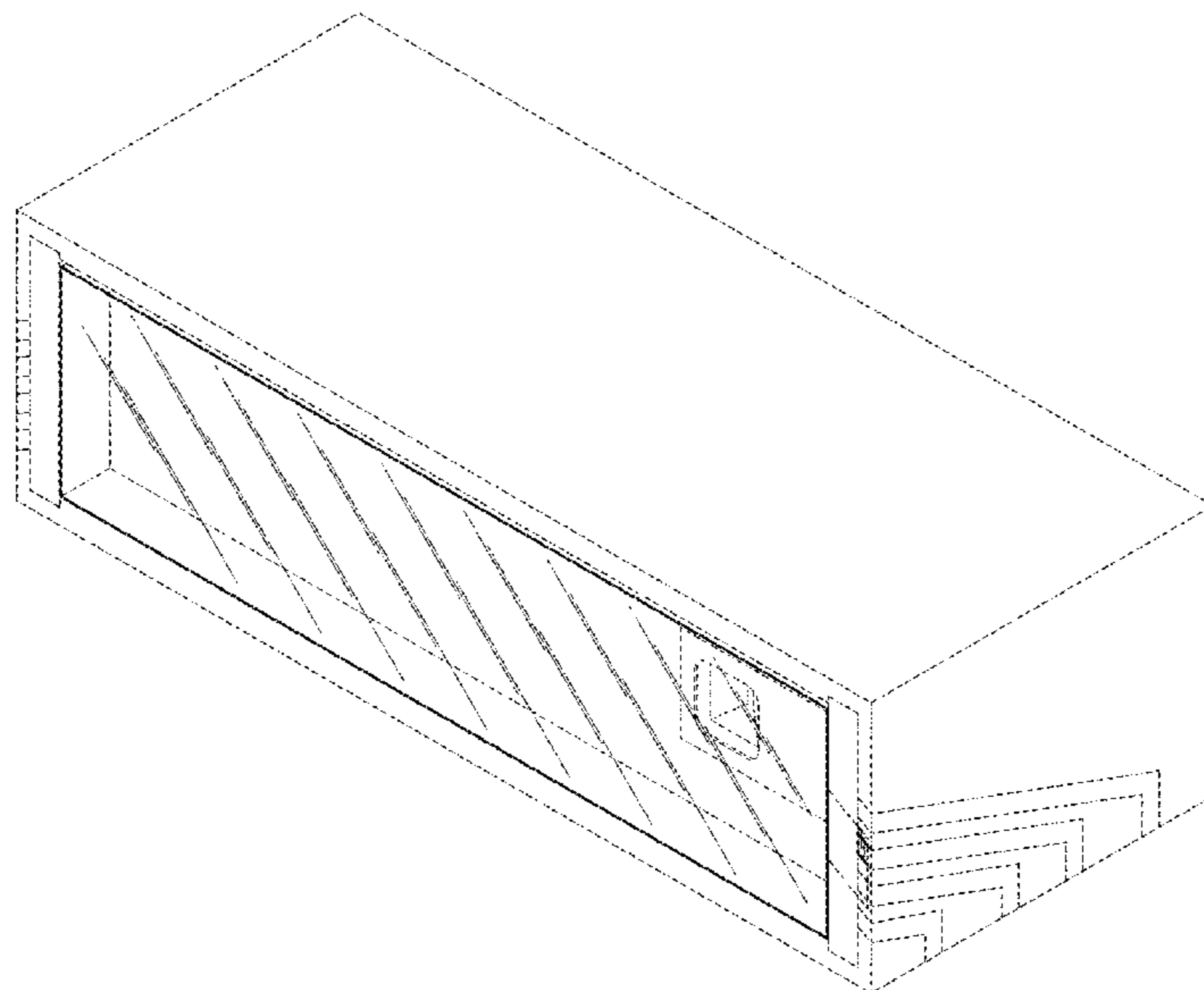
DESCRIPTION

FIG. 1 is a perspective view of a spectrometer;
FIG. 2 is a front view of the spectrometer of FIG. 1;
FIG. 3 is a back view of the spectrometer of FIG. 1;
FIG. 4 is a top view of the spectrometer of FIG. 1;
FIG. 5 is a bottom view of the spectrometer of FIG. 1;
FIG. 6 is a left view of the spectrometer of FIG. 1;
FIG. 7 is a right view of the spectrometer of FIG. 1; and,
FIG. 8 is a sectional view taken along the line 8-8 of the spectrometer of FIG. 2.

The broken lines show portions of a spectrometer that form no part of the claimed design.

The dash-dot broken lines seen in FIGS. 1 and 2 show the bounds of the claimed design, and form no part thereof.

1 Claim, 8 Drawing Sheets



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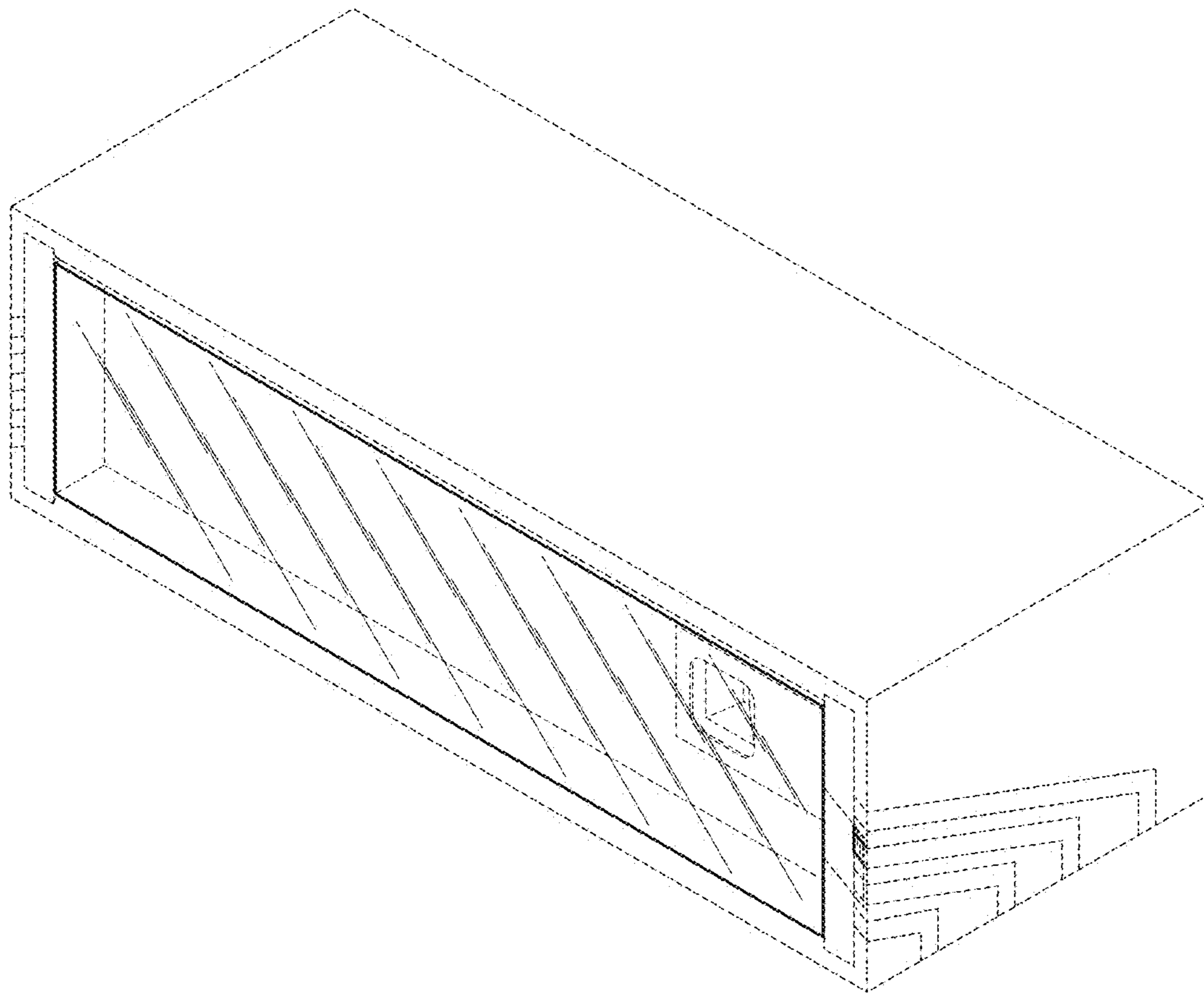


FIG. 1

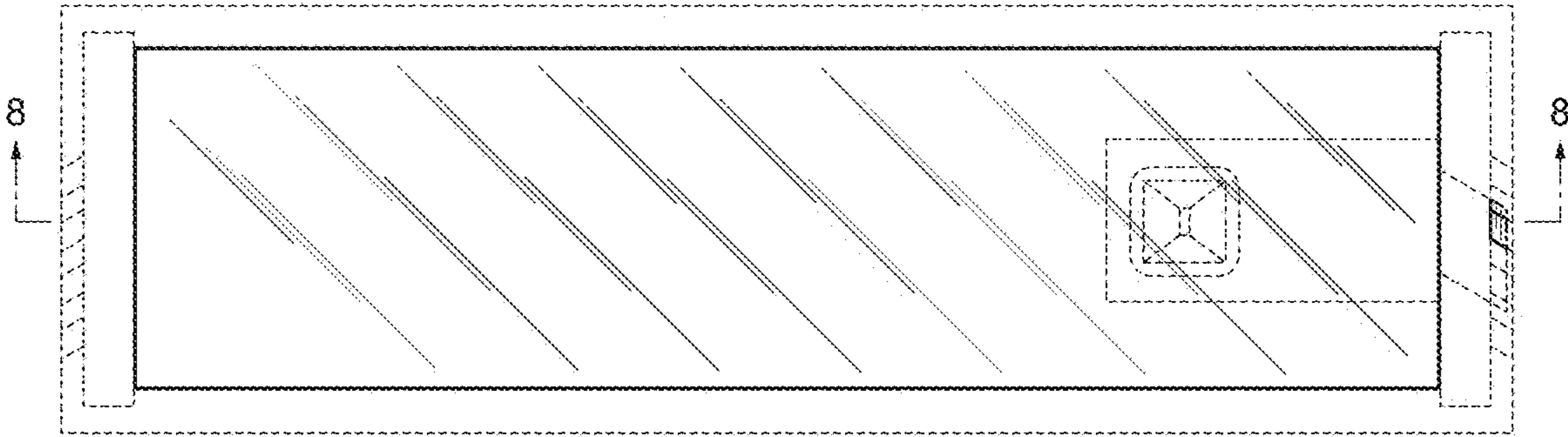


FIG. 2



FIG. 3



FIG. 4

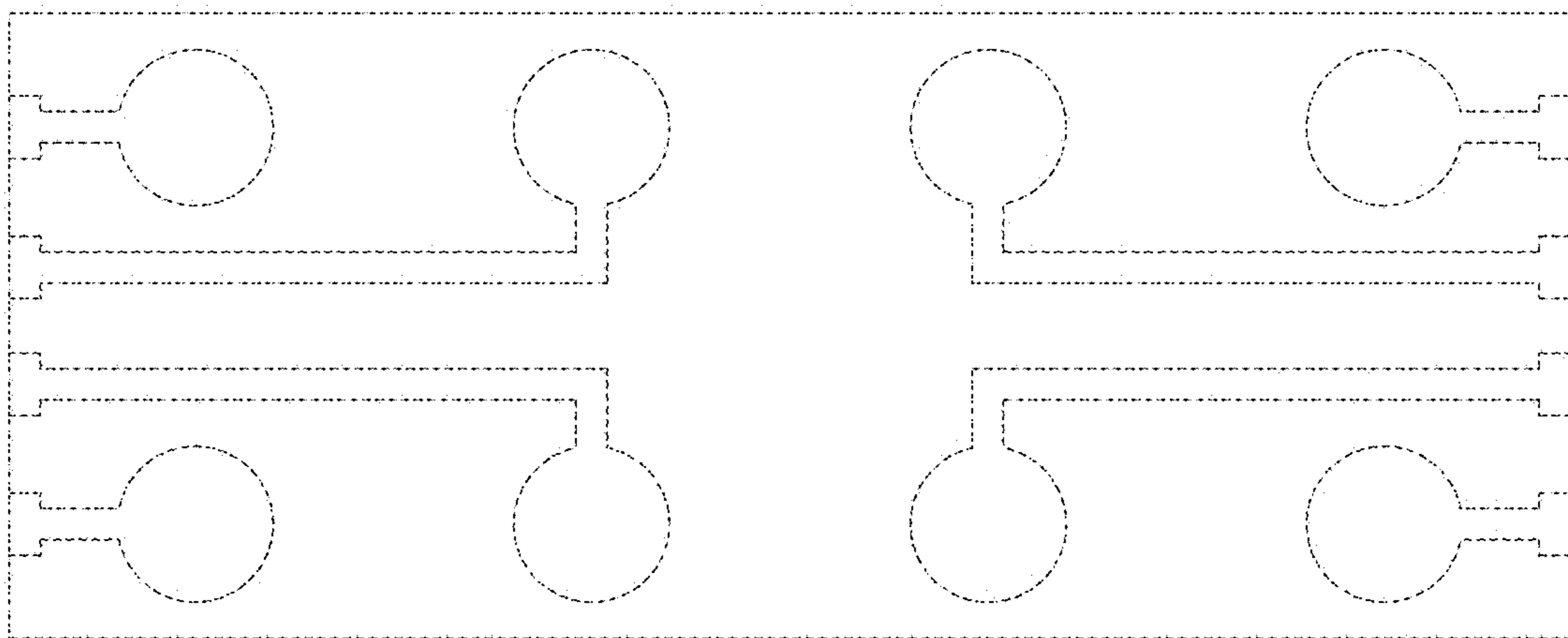


FIG. 5

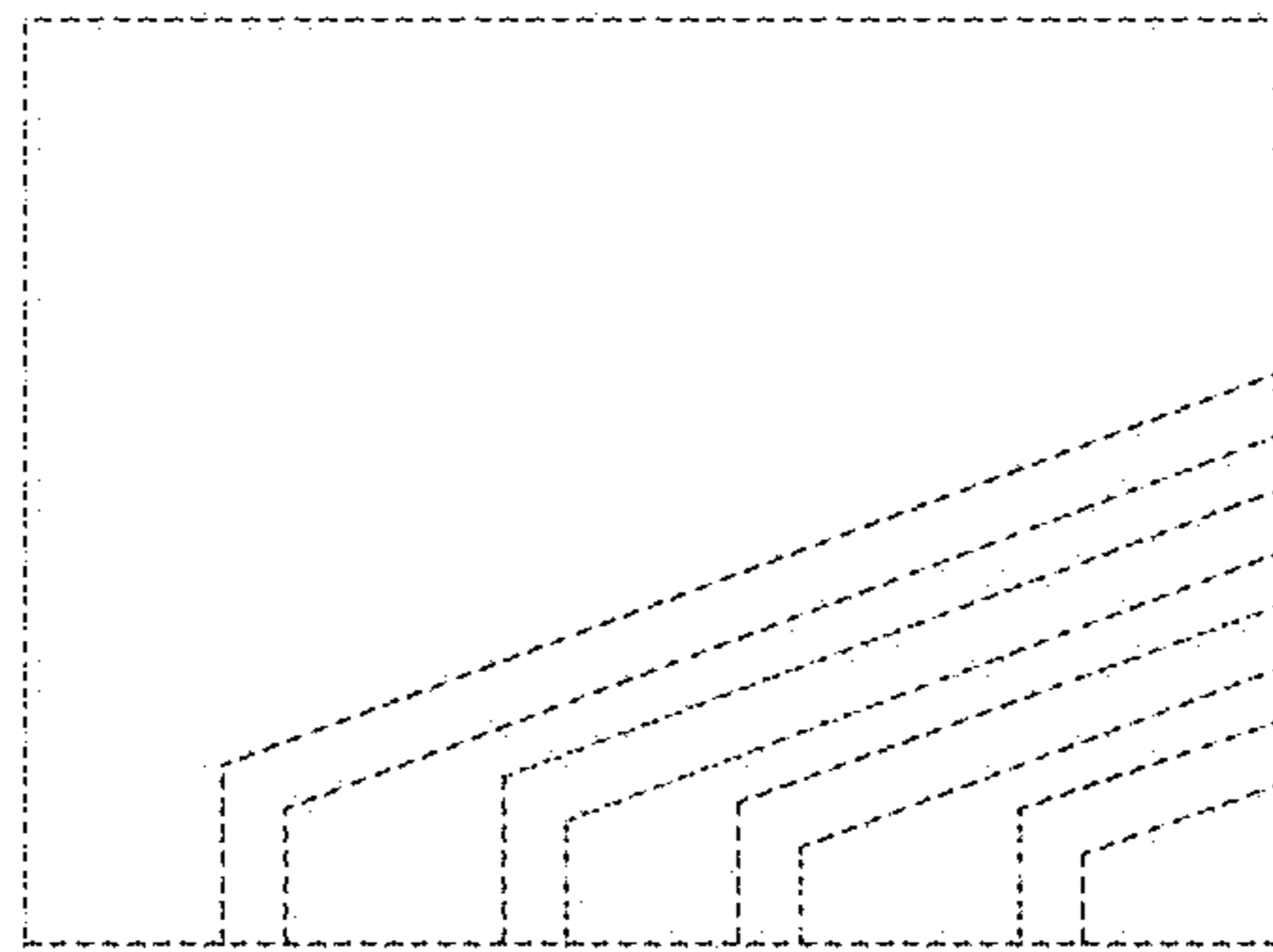


FIG. 6

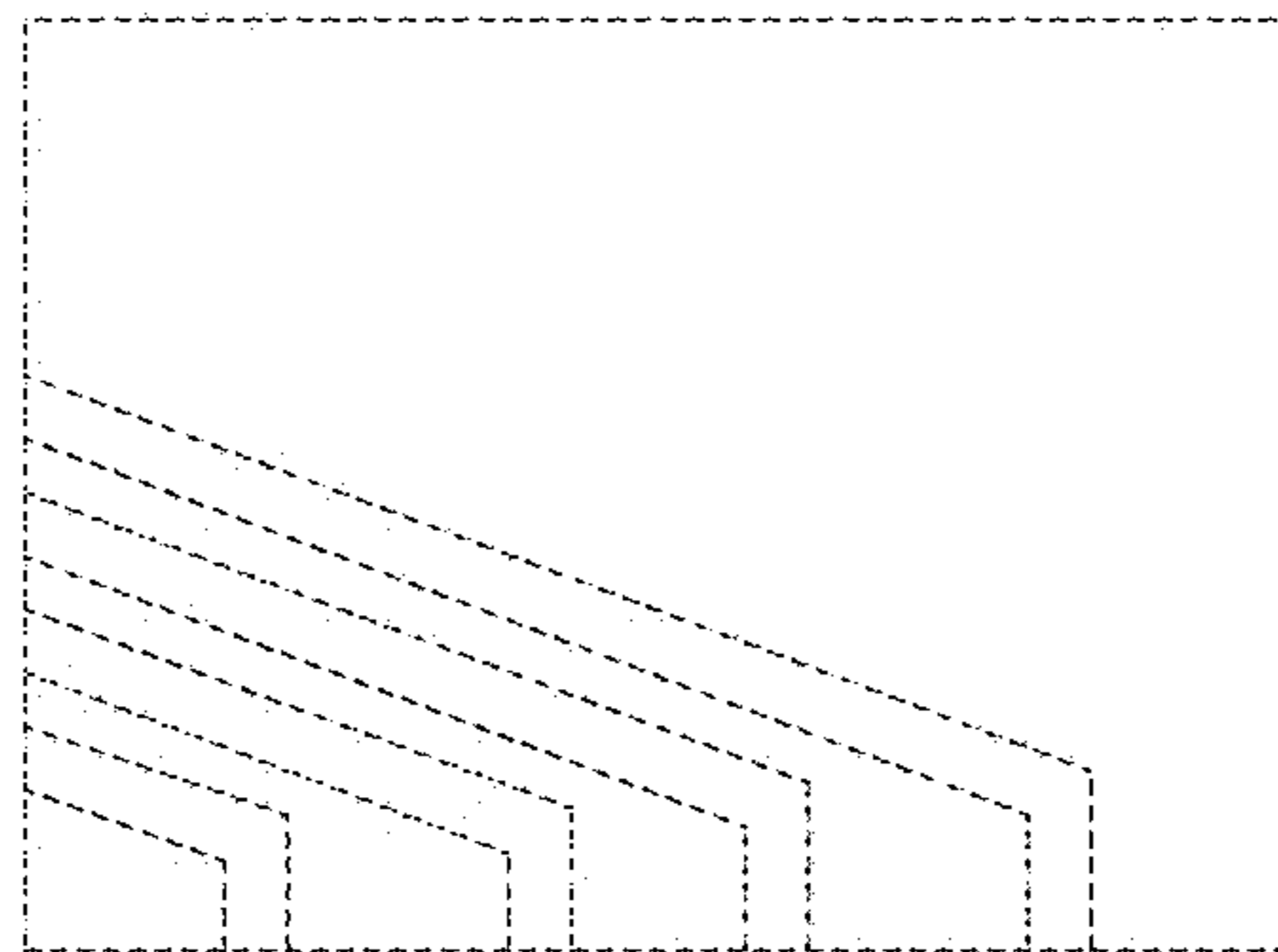


FIG. 7

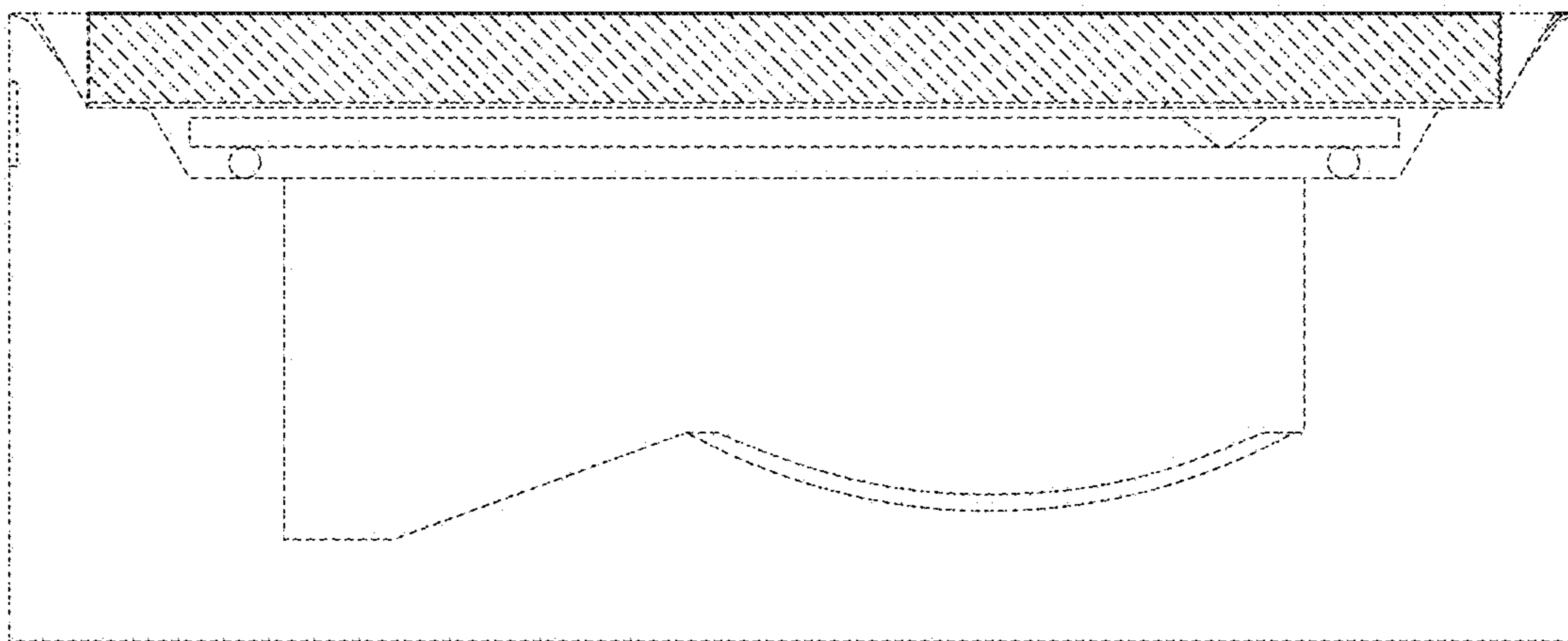


FIG. 8